

<b>Notic of Referenc s Cit d</b>	Application/Control No. 09/733,104	Applicant(s)/Patent Under Reexamination TEIG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5650653 - A	07-1997	Rostoker et al.	257/369
	C	US-			
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	K	US-			
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**NON-PATENT DOCUMENTS**

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